

WHAT IS CLAIMED IS:

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1. Method of information collection and processing of sample's surface, including successive reading of at least a portion of force curve, in predetermined points of surface under control within the process of approach and/or move apart (which goes after reverse) of sample and probe, which is set up at cantilever, and determination (according to it) of sample's parameters with further construction of appropriate space distributions, which differs by, that choice of points of control is carried out and values of cantilever's deviation force are noted within reading of at least a portion of force curve, as well as: and/or coordinates of its fixed end are; and/or derivatives from cantilever's deviation force of coordinate of its fixed end are at least in points of control of force curve, upon that, parameters of sample, characterizing relief and/or properties of sample's surface and/or a number and properties of its surface layers are determined by a number of points of control, and/or noted values of cantilever's deviation force, and/or coordinates of its fixed end, and/or derivatives from cantilever's deviation force of coordinate of its fixed end in appropriate points of control.

2. Method, as set forth in claim 1, differing by, that coordinates of sample's surface and/or of limits of their surface layers, or thickness of surface layers, or adhesion force of sample's surface and/or surface layers, or elasticity coefficient of sample's surface and/or surface layers, or frictional force of sample's surface and/or surface layers are used in the character of parameters, characterizing relief and/or properties of sample's surface and/or a number and properties of its surface layers.

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3. Method, as set forth in claims 1 and 2, differing by, that a set of arguments are formed by values of cantilever's deviation force and/or coordinate of its fixed end and/or derivatives from cantilever's deviation force of coordinate of its

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fixed end at least in points of control; determination of parameters is carried out by the way of forming of a set of functions, using received arguments and determination of their values.

4. Method, as set forth in claims 1-3, differing by, that points, limiting quasi-rectilinear portions of force curve, and/or points, where force curve shifts slope jumpy, are chosen as points of control.

5. Method, as set forth in claims 1-3, differing by, that points, where coordinate of fixed end of cantilever and/or force of its deviation and/or its first or second derivatives according to coordinate of fixed cantilever's end, achieve threshold values, received, e.g., using results of previous scanning or measurement are chosen as points of control.

6. Method, as set forth in claims 1-5, differing by, that construction of space distributions is carried out concerning coordinate of sample's surface.

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7. Method, as set forth in claim 1, differing by, that choosing of points of control and/or noting of values of cantilever's deviation force, and/or coordinates of its fixed end, and/or derivatives from cantilever's deviation force of coordinate of its fixed end, are carried out after filtration of a set of current values of cantilever's deviation force and coordinates of its fixed end.

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8. Method, as set forth in claims 1-3, differing by, that determination of parameters, using noted values of cantilever's deviation force and/or coordinates of its fixed end and/or derivatives from cantilever's deviation force of coordinate of its fixed end in a predetermined subset of points of control is carried out, taking into consideration values of indicated magnitudes in other subsets of points of control.

[illegible]

11. Method, as set forth in claim 10, differing by, that initial points of quasi-vertical portions are not taken into account upon determination of a number of surface layers of sample.

$$R_o = Z_o - S_o$$

Zo, So is coordinate of fixed cantilever's end and magnitude of deviation of its free end at the moment of achievement (by cantilever's deviation force) of a value, equal to 0 or $-A$ within approach of sample and probe, and 0 or $+A$ within move apart of sample and probe, accordingly,

A is positive constant magnitude.

14. Method, as set forth in claim 2, differing by, that coordinates of limits of surface layers of sample are determined as coordinates of fixed cantilever's end in points of control, not including initial points of quasi-vertical portions within approach of sample and probe and final points of quasi-vertical portions within move apart of sample and probe.

$R_i = Z_i - S_i$, $D_i = [R(i+1) - R_i]$, where R_i and D_i are coordinate of limit of i -layer and its thickness accordingly, $i = (0, 1, 2, \dots)$,

16. Method, as set forth in claim 2, differing by, that coordinates of limits of surface layers of sample relatively sample's surface and their thicknesses are determined according to relationships like:

Zi, Si are coordinate of cantilever's fixed end and magnitude of deviation of its free end accordingly in an appropriate point of control, not including initial

points of quasi-vertical portions within approach of sample and probe and final points of quasi-vertical portions within move apart of sample and probe.

17. Method, as set forth in claims 14-16, differing by, that coordinates of limits of surface layers of sample (measured within approach or move apart), are determined relatively coordinate of surface, which is measured also within move apart or approach accordingly.

18. Method, as set forth in claim 2, differing by, that adhesion force of surface layers of sample is determined by values of cantilever's deviation force in points of control, not including final points of quasi-vertical portions within move apart of sample and probe.

19. Method, as set forth in claim 2, differing by, that summary adhesion force of surface and surface layers of sample is determined as an absolute maximum of cantilever's deviation force within the process of move apart of probe and sample.

20. Method, as set forth in claim 2, differing by, that coordinate of sample's surface is determined with a correction for summary adhesion force, which takes place between probe and surface, according to relationship:

$R_{oa} = R_o + F_{ac}/K_p$, where R_{oa} is coordinate of sample's surface with a correction taking into account summary adhesion force, which takes place between probe and surface,

F_{ac} is summary adhesion force of sample's surface,

$K_p = K_k * \text{tg}\alpha / (1 - \text{tg}\alpha)$,

K_k is coefficient of cantilever's elasticity for bending,

$\text{tg}\alpha$ is slope of force curve in the vicinity of point Z_o .

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where Roy is surface coordinate.

[illegible]

$tg\alpha$ is slope of a portion of force curve, placed between appropriate points of control, B is coefficient of proportionality.

where K_p is coefficient of elasticity of sample's surface.

24. Method, as set forth in claim 2, differing by, that approach and/or move apart of sample and probe are carried out before achievement of threshold value by cantilever's deviation force.

25. Method, as set forth in claim 1, differing by, that reading of force curve is carried out more than one time in predetermined points of sample's surface under control.

30. Method, as set forth in claim 1, differing by, that registration of magnitude of tunnel current between conducting probe and sample's surface is carried out together with reading of force curve or of its portion, using received set of

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values for construction of distribution of electric conduction of surface and/or surface layers of sample.

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